

Search Notes



Application/Control No.

10/665,920

Examiner

Hiep Nguyen

Applicant(s)/Patent under Reexamination

MILLER, EDWARD E.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	205	01.28.05	Mr
	77	I	I
	537		
	407		
	408		
	63		
	65		
327	206	07.07.05	Mr
	207	-	-
MA Search update		07.21.05	Mr

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
327	205	07.21.05	Mr
	77	I	I
	206	I	I

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	01.28.05	Mr
EAST	07.05.05	Mr
EAST See attachment	07.21.05	Mr